Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/765,411	ISHIZAWA ET AL.	
Examiner	Art Unit	
Anh T.N. Vo	2861	

	SEARCHED				
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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